

10/667,879

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	0	(test system AND burn-in configuration register AND combinational logic AND ID scan data signal AND memory BIST signal AND exclusive-OR logic AND monitored output signal).clm.	US-PGPUB; USPAT	ADJ	ON	2006/07/06 12:07
L2	0	(test system AND burn-in configuration register AND combinational logic AND ID scan data signal AND memory BIST signal AND scan chain signal AND exclusive-OR AND monitored output signal).clm.	US-PGPUB; USPAT	ADJ	ON	2006/07/06 12:06

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L1	0	(test system AND burn-in configuration register AND combinational logic AND ID scan data signal AND memory BIST signal AND exclusive-OR logic AND monitored output signal).clm.	US-PGPUB; USPAT	ADJ	ON	2006/07/06 12:07
L2	0	(test system AND burn-in configuration register AND combinational logic AND ID scan data signal AND memory BIST signal AND scan chain signal AND exclusive-OR AND monitored output signal).clm.	US-PGPUB; USPAT	ADJ	ON	2006/07/06 12:06
L3	1	burn-in configuration register\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:11
L4	8227	combinational logic	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:07
L5	1	DIE ID scan out signal\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:09
L6	3	memory built-in self-test signal\$1 or memory BIST signal\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:12
L7	2817833	exclusive-OR logic or exclusive-OR gate\$1 or ex-OR\$3 or compar\$3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:09

EAST Search History

L8	1	ID scan out signal\$1 or identification scan data signal\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:13
L9	1	I6 and I7 and I4 and I3	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:10
L11	7	burn-in register\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:11
L12	393	memory built-in self-test or memory BIST	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:12
L13	0	I7 and (I4 and I11 and I12)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:13
L14	4904	I7 and (I4 or I11 or I12)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:13
L15	50	ID same scan out signal\$1 or identification same scan data signal\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:13
L16	1	I14 and I15	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:14

EAST Search History

L17	5264	714/726 or 714/724 or 714/733 or 714/734 or 714/30	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:14
L18	325	I14 and I17	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:14
L19	3688	scan chain\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:15
L20	158	I18 and I19	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:15
L21	1	(Die ID Scout Enable register\$1)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:16
L22	1	MBIST fail enable register\$1	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:16
L23	1	SCOUT CHAIN enable	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:16
L24	0	BURNIN-MONITOR	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:16

EAST Search History

L25	0	BURN-IN-MONITOR	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:17
L26	202	MBIST	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:17
L27	3	L26 and L20	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	ADJ	ON	2006/07/06 12:25